

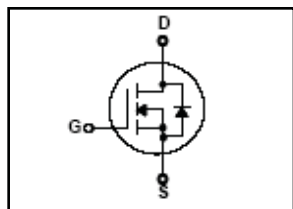
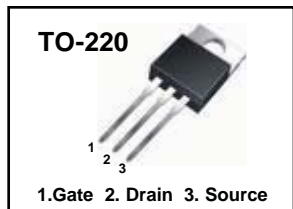
# HFP13N65U

## 650V N-Channel MOSFET

$BV_{DSS} = 650\text{ V}$   
 $R_{DS(on) \text{ typ}} = 0.4\ \Omega$   
 $I_D = 14.0\text{ A}$

### FEATURES

- Originative New Design
- Superior Avalanche Rugged Technology
- Robust Gate Oxide Technology
- Very Low Intrinsic Capacitances
- Excellent Switching Characteristics
- Unrivalled Gate Charge : 60.0 nC (Typ.)
- Extended Safe Operating Area
- Lower  $R_{DS(ON)}$  : 0.4  $\Omega$  (Typ.) @  $V_{GS}=10\text{V}$
- 100% Avalanche Tested



### Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	650	V
$I_D$	Drain Current – Continuous ( $T_C = 25^\circ\text{C}$ )	14.0	A
	Drain Current – Continuous ( $T_C = 100^\circ\text{C}$ )	8.8	A
$I_{DM}$	Drain Current – Pulsed (Note 1)	56.0	A
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	810	mJ
$I_{AR}$	Avalanche Current (Note 1)	14.0	A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	23.0	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5	V/ns
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ ) - Derate above $25^\circ\text{C}$	230	W
		1.84	W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

### Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	0.54	$^\circ\text{C/W}$
$R_{\theta CS}$	Case-to-Sink	0.5	--	
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

## Package Marking and Odering Information

Device Marking	Week Marking	Package	Packing	Quantity	RoHS Status
HFP13N65U	YWWX	TO-220	Tube	50	Pb Free
HFP13N65U	YWWXg	TO-220	Tube	50	Halogen Free

## Electrical Characteristics $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### On Characteristics

$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2.5	--	4.5	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 7.0 \text{ A}$	--	0.4	0.5	$\Omega$

### Off Characteristics

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	650	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.6	--	$\text{V}/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{DS} = 520 \text{ V}, T_C = 125^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	--	--	$\pm 100$	nA

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$	--	3200	4160	pF
$C_{oss}$	Output Capacitance		--	250	330	pF
$C_{rss}$	Reverse Transfer Capacitance		--	16.0	21.0	pF

### Switching Characteristics

$t_{d(on)}$	Turn-On Time	$V_{DS} = 325 \text{ V}, I_D = 14.0 \text{ A},$ $R_G = 25 \Omega$	--	95	190	ns
$t_r$	Turn-On Rise Time		--	90	180	ns
$t_{d(off)}$	Turn-Off Delay Time		--	360	720	ns
$t_f$	Turn-Off Fall Time		(Note 4,5)	--	90	180
$Q_g$	Total Gate Charge	$V_{DS} = 520 \text{ V}, I_D = 14.0 \text{ A},$ $V_{GS} = 10 \text{ V}$	--	60.0	78.0	nC
$Q_{gs}$	Gate-Source Charge		--	16.0	--	nC
$Q_{gd}$	Gate-Drain Charge		(Note 4,5)	--	17.0	--

### Source-Drain Diode Maximum Ratings and Characteristics

$I_S$	Continuous Source-Drain Diode Forward Current	--	--	14.0	A	
$I_{SM}$	Pulsed Source-Drain Diode Forward Current	--	--	56		
$V_{SD}$	Source-Drain Diode Forward Voltage	$I_S = 14.0 \text{ A}, V_{GS} = 0 \text{ V}$	--	--	1.4	V
$t_{rr}$	Reverse Recovery Time	$I_S = 14.0 \text{ A}, V_{GS} = 0 \text{ V}$ $di_F/dt = 100 \text{ A}/\mu\text{s}$ (Note 4)	--	377	--	ns
$Q_{rr}$	Reverse Recovery Charge		--	8.2	--	$\mu\text{C}$

#### Notes ;

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L=7.6\text{mH}, I_{AS}=14.0\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
3.  $I_{SD}\leq 14.0\text{A}, di/dt\leq 200\text{A}/\mu\text{s}, V_{DD}\leq BV_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
4. Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
5. Essentially Independent of Operating Temperature

Typical Characteristics

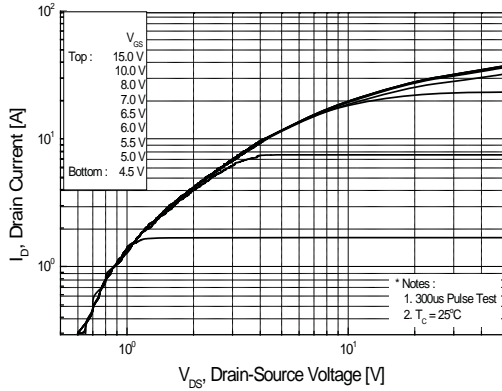


Figure 1. On Region Characteristics

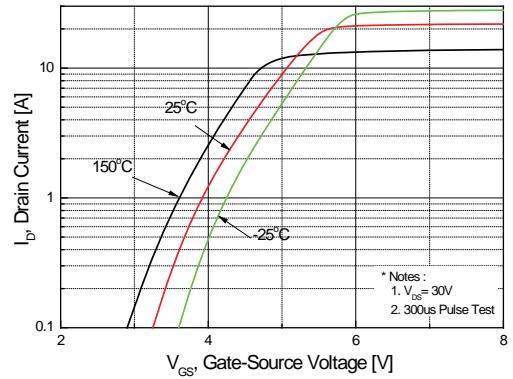


Figure 2. Transfer Characteristics

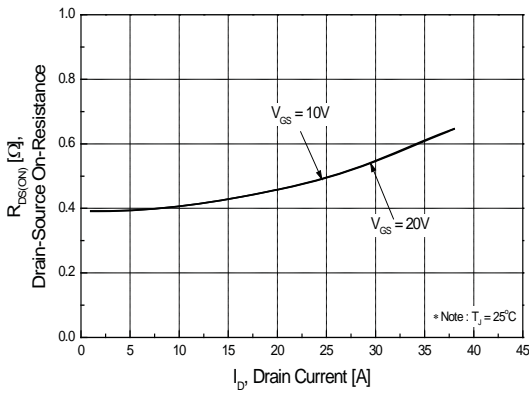


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

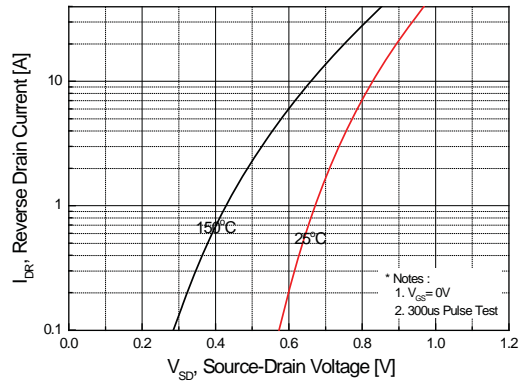


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

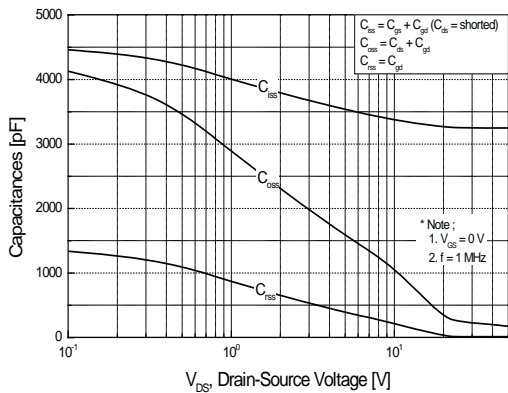


Figure 5. Capacitance Characteristics

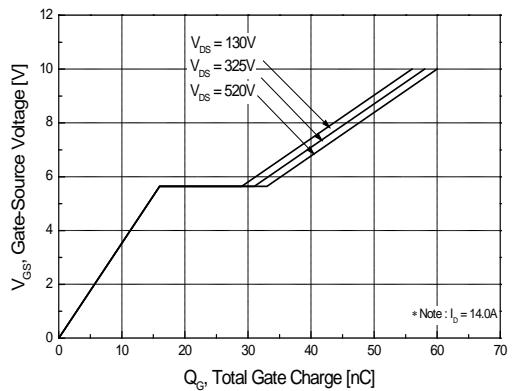


Figure 6. Gate Charge Characteristics

Typical Characteristics (continued)

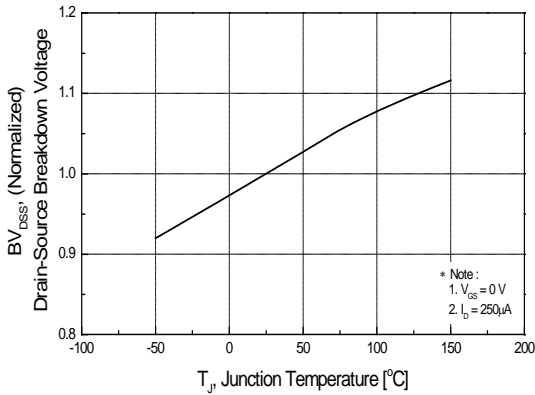


Figure 7. Breakdown Voltage Variation vs Temperature

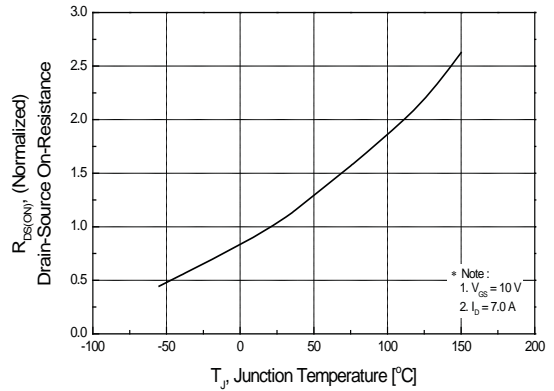


Figure 8. On-Resistance Variation vs Temperature

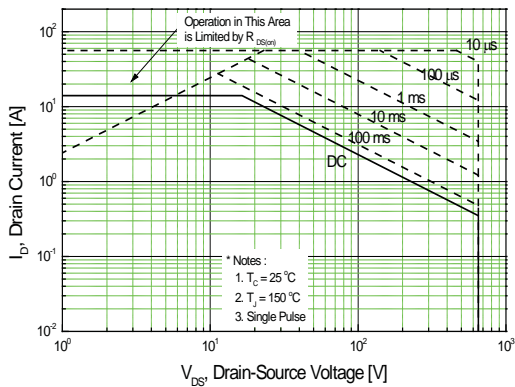


Figure 9. Maximum Safe Operating Area

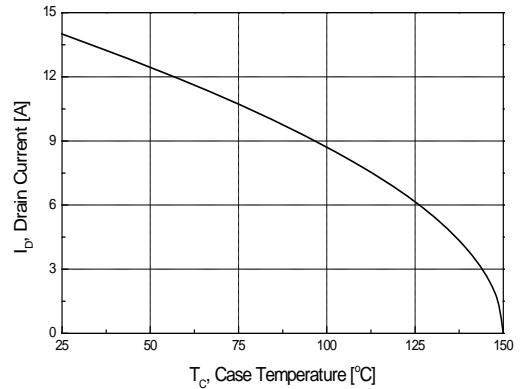


Figure 10. Maximum Drain Current vs Case Temperature

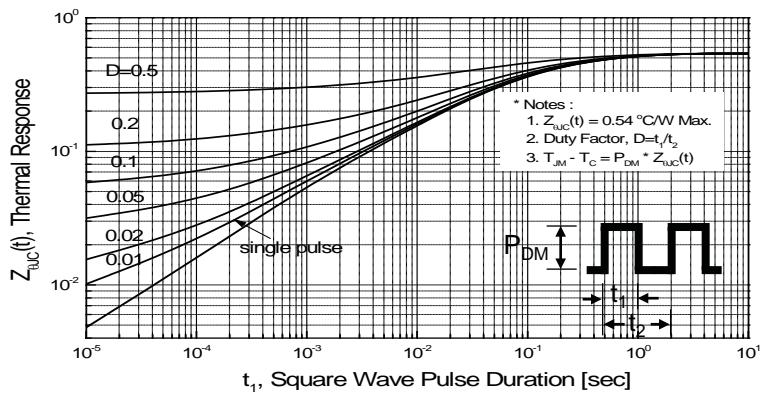


Figure 11. Transient Thermal Response Curve

Fig 12. Gate Charge Test Circuit & Waveform

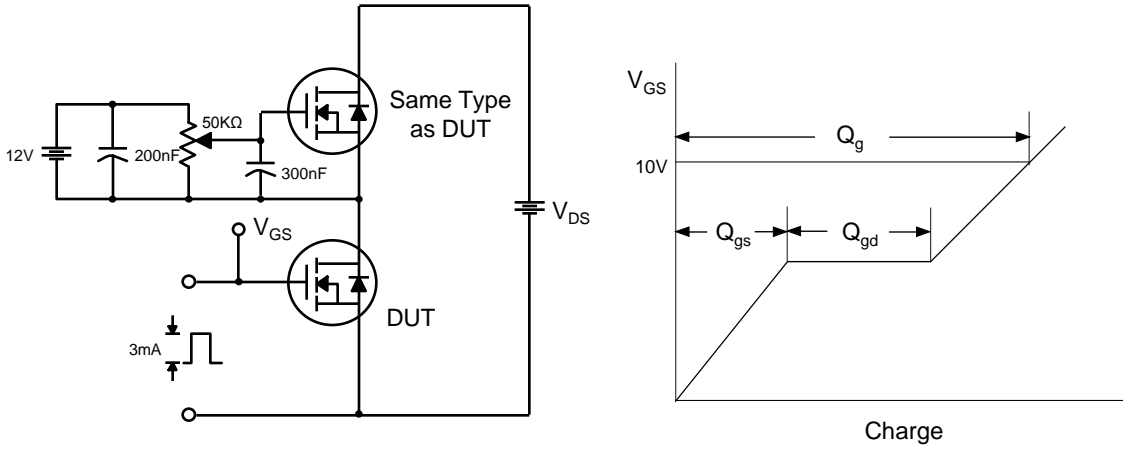


Fig 13. Resistive Switching Test Circuit & Waveforms

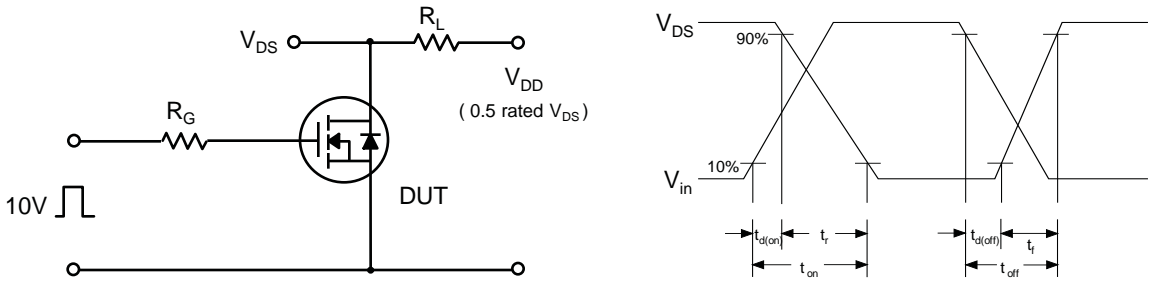


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

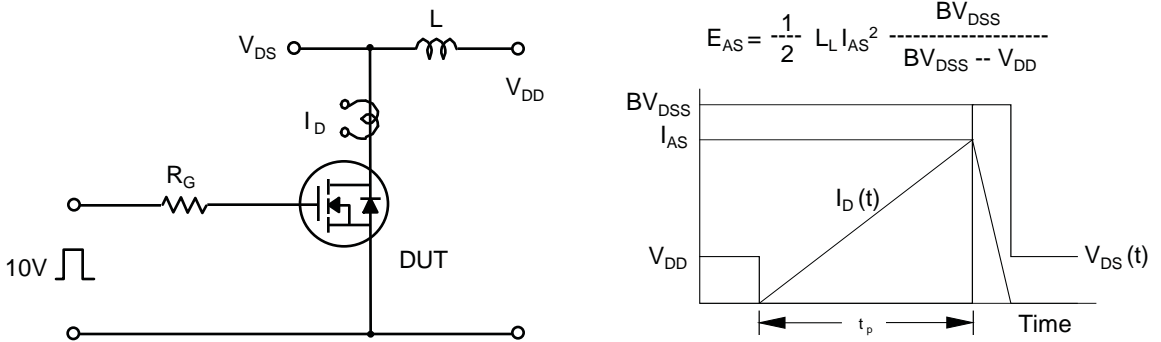
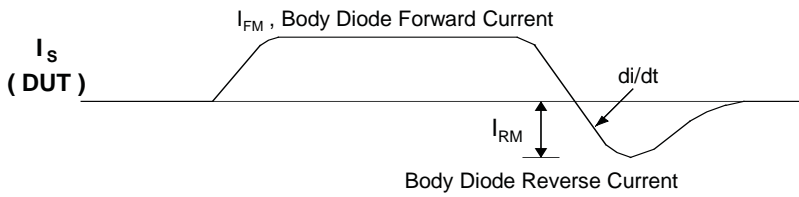
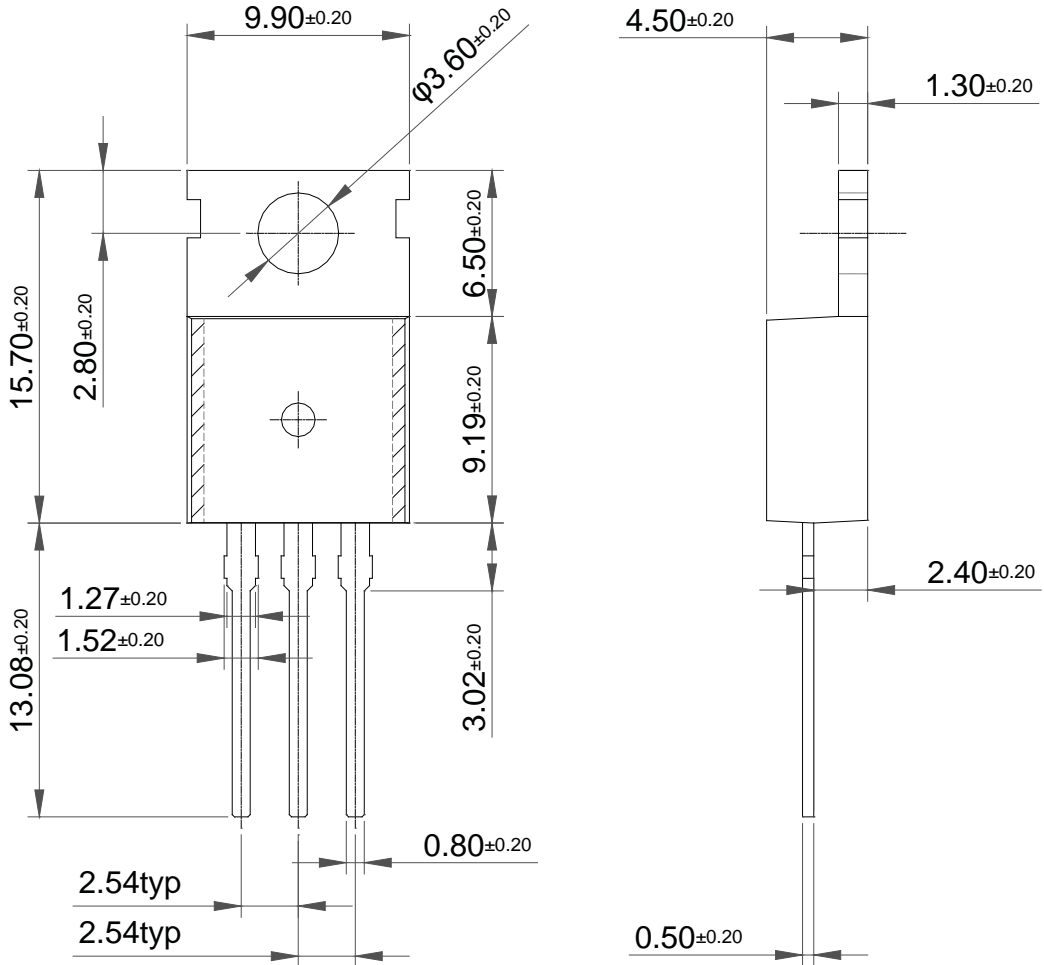


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package Dimension

TO-220 (A)



Package Dimension

TO-220 (B)

